

Notice of References Cited	Application/Control No. 09/923,810	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner A. Sefer	Art Unit 2826	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,852,481	12-1998	Hwang, Kwang Jo	349/43
	B	US-6,509,215	01-2003	Fujikawa et al.	438/151
	C	US-6,215,541	04-2001	Song et al.	349/141
	D	US-6,335,211	01-2002	Lee, Kyung-Nam	438/22
	E	US-6,130,443	10-2000	Hong et al.	257/59
	F	US-5,825,437	10-1998	Seo et al.	349/46
	G	US-6,376,861	04-2002	Yaegashi et al.	257/59
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2000-77669	03-2000	Japan		
	O	JP 2000-199912	07-2000	Japan		
	P	JP 6-294973	10-1994	Japan		
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.